Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | EGAN ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,381,554 A	01-1995	Langer et al.	714/14
*	В	US-5,949,974	09-1999	Ewing et al.	709/202
*	С	US-6,041,414 A	03-2000	Kikuchi, Kazuhito	713/300
*	D	US-6,757,835 B2	06-2004	Kano et al.	713/340
*	Ε	US-6,882,943 B1	04-2005	Quelch, Paul Jonathan	702/64
*	F	US-2004/0177283 A1	09-2004	Madany et al.	713/300
*	G	US-2003/0085624 A1	05-2003	Kadoi et al.	307/64
*	Ξ	US-2005/0071699 A1	03-2005	Hammond et al.	713/300
*	-	US-2005/0086543 A1	04-2005	Manuell et al.	713/300
	٦	US-			
	К	US-	_		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2005/031520 A2	04-2005	WIPO	Ives, Edward M.	
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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